



INTELLECTUAL PROPERTY  
402-391-4448

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Assistant Commissioner  
for Patents  
Patent & Trademark Office  
Washington, D.C. 20231

RE: PROTEST BY THIRD PARTY REGARDING APPLICATION OF  
OTSUKI ET AL. TITLED: "SPECTRAL ELLIPSOMETER WITHOUT  
CHROMATIC ABERATIONS";  
PUB. NO. US2002/0126284 A1;  
PUB. DATE: SEPT. 1A, 2002;  
SERIAL NO. 10/004250.

PROTEST OF U.S. PATENT APPLICATION

Dear Sir;

Enclosed please find Two (2) copies of

U.S. Patent 5,166,752;  
Article by Collins titled "Real-Time Spectroscopic  
Ellipsometry from 1.6 to 6.5 ev";

which it is believed should be considered in examination of the  
identified Application as they describe spectroscopic  
ellipsometers.

Service was not made on the Applicant.

Sincerely,

JAMES D. WELCH  
JW/hs  
enc.